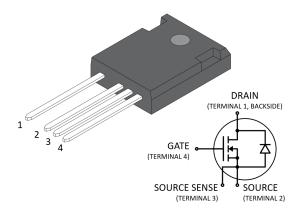


MSC017SMA120B4 Silicon Carbide N-Channel Power MOSFET

Product Overview

The silicon carbide (SiC) power MOSFET product line from Microsemi increases the performance over silicon MOSFET and silicon IGBT solutions while lowering the total cost of ownership for high-voltage applications. The MSC017SMA120B4 device is a 1200 V, 17 m Ω SiC MOSFET in a TO-247 package with a source sense.



Features

The following are key features of the MSC017SMA120B4 device:

- Low capacitances and low gate charge
- Fast switching speed due to low internal gate resistance (ESR)
- Stable operation at high junction temperature, T_{J(max)} = 175 °C
- · Fast and reliable body diode
- Superior avalanche ruggedness
- RoHS compliant

Benefits

The following are benefits of the MSC017SMA120B4 device:

- High efficiency to enable lighter, more compact system
- Simple to drive and easy to parallel
- · Improved thermal capabilities and lower switching losses
- · Eliminates the need for external freewheeling diode
- Lower system cost of ownership

Applications

The MSC017SMA120B4 device is designed for the following applications:

- PV inverter, converter, and industrial motor drives
- · Smart grid transmission and distribution
- Induction heating and welding
- H/EV powertrain and EV charger
- Power supply and distribution



Device Specifications

This section shows the specifications of the MSC017SMA120B4 device.

Absolute Maximum Ratings

The following table shows the absolute maximum ratings of the MSC017SMA120B4 device.

Table 1 • Absolute Maximum Ratings

Symbol	Parameter	Ratings	Unit
V _{DSS}	Drain source voltage	1200	V
I _D	Continuous drain current at T _C = 25 °C	113	А
	Continuous drain current at T _C = 100 °C	80	
I _{DM}	Pulsed drain current ¹	280	
V _{GS}	Gate-source voltage	23 to –10	V
P _D	Total power dissipation at T _C = 25 °C	455	w
	Linear derating factor	3.33	w/°c

Note:

1. Repetitive rating: pulse width and case temperature limited by maximum junction temperature.

The following table shows the thermal and mechanical characteristics of the MSC017SMA120B4 device.

Table 2 • Thermal and Mechanical Characteristics

Symbol	Characteristic		Тур	Max	Unit
R _{θJC}	Junction-to-case thermal resistance		0.22	0.33	°C/W
T _J	Operating junction temperature	-55		175	°C
T _{STG}	Storage temperature	-55		150	
T _L	Soldering temperature for 10 seconds (1.6 mm from case)			300	
	Mounting torque, 6-32 or M3 screw			10	lbf-in
				1.1	N-m
Wt	Vt Package weight		0.22		OZ
			6.2		g



Electrical Performance

The following table shows the static characteristics of the MSC017SMA120B4 device. T_J = 25 °C unless otherwise specified.

Table 3 • Static Characteristics

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V, I}_{D} = 100 \mu\text{A}$	1200			V
R _{DS(on)}	Drain-source on resistance ¹	V _{GS} = 20 V, I _D = 40 A		17.6	22	mΩ
V _{GS(th)}	Gate-source threshold voltage	$V_{GS} = V_{DS}$, $I_D = 4.5 \text{ mA}$	1.9	2.7		V
$\Delta V_{GS(th)}/\Delta T_J$	Threshold voltage coefficient	$V_{GS} = V_{DS}$, $I_D = 4.5 \text{ mA}$		-4.6		mV/°C
I _{DSS}	Zero gate voltage drain current	V _{DS} = 1200 V, V _{GS} = 0 V			100	μА
		V _{DS} = 1200 V, V _{GS} = 0 V T _J = 125 °C			500	
I _{GSS}	Gate-source leakage current	V _{GS} = 20 V/–10 V			±100	nA

Note:

1. Pulse test: pulse width < 380 μ s, duty cycle < 2%.



The following table shows the dynamic characteristics of the MSC017SMA120B4 device. T_J = 25 °C unless otherwise specified.

Table 4 • Dynamic Characteristics

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
C _{iss}	Input capacitance	$V_{GS} = 0 \text{ V}, V_{DD} = 1000 \text{ V}$ $V_{AC} = 25 \text{ mV}, f = 1 \text{ MHz}$		5280		pF
C _{rss}	Reverse transfer capacitance			12		
C _{oss}	Output capacitance			265		
Q _g	Total gate charge	$V_{GS} = -5 \text{ V/20 V}, V_{DD} = 800 \text{ V}$ $I_D = 40 \text{ A}$		249		nC
Q_{gs}	Gate-source charge			63		
Q_{gd}	Gate-drain charge			32		
t _{d(on)}	Turn-on delay time	$V_{DD} = 800 \text{ V}, V_{GS} = -5 \text{ V}/20 \text{ V},$ $I_D = 50 \text{ A}, R_{COM} = 4.0 \text{ O}.$		29		ns
t_f	Voltage fall time	I _D = 50 A, R _{g(ext)} = 4.0 Ω, Freewheeling diode = MSC017SMA120B4		18		
t _{d(off)}	Turn-off delay time			51		
t _r	Voltage rise time			13		
E _{on}	Turn-on switching energy			684		μ
E _{off}	Turn-off switching energy			195		
t _{d(on)}	Turn-on delay time	$V_{DD} = 800 \text{ V}, V_{GS} = -5 \text{ V}/20 \text{ V},$ $I_D = 50 \text{ A}, R_{g(ext)} = 4.0 \Omega$		29		ns
t _f	Voltage fall time	Freewheeling diode = MSC050SDA120B		15		
t _{d(off)}	Turn-off delay time	WSCOSOSDATZOD		51		
t _r	Voltage rise time			12		
E _{on}	Turn-on switching energy			509		μ
E _{off}	Turn-off switching energy			211		
ESR	Equivalent series resistance	f = 1 MHz, 25 mV, drain short		0.71		Ω
SCWT	Short circuit withstand time	V _{DS} = 960 V, V _{GS} = 20 V		3		μs
E _{AS}	Avalanche energy, single pulse	V _{DS} = 150 V, I _D = 30 A		3500		mJ



The following table shows the body diode characteristics of the MSC017SMA120B4 device. T_J = 25 °C unless otherwise specified.

Table 5 • Body Diode Characteristics

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
V _{SD}	Diode forward voltage	$I_{SD} = 40 \text{ A, } V_{GS} = 0 \text{ V}$		3.5		V
		$I_{SD} = 40 \text{ A}, V_{GS} = -5 \text{ V}$		3.9		V
t _{rr}	Reverse recovery time	I_{SD} = 60 A, V_{GS} = -5 V V_{DD} = 800 V, dl/dt = -8000 A/μs, Drive Rg = 4.0 Ω		17		ns
Q _{rr}	Reverse recovery charge			678		nC
I _{RRM}	Reverse recovery current			64		А

Typical Performance Curves

This section shows the typical performance curves of the MSC017SMA120B4 device.

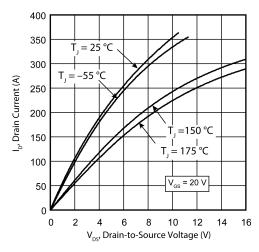


Figure 1 • Drain Current vs. V_{DS}

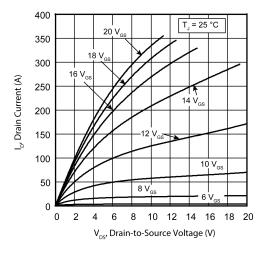


Figure 2 • Drain Current vs. V_{DS}



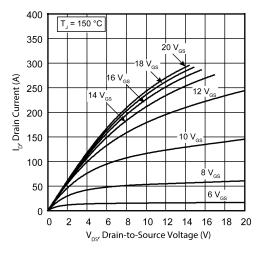


Figure 3 • Drain Current vs. V_{DS}

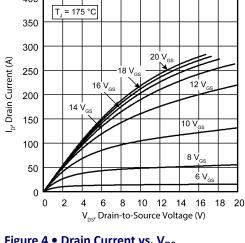


Figure 4 ● Drain Current vs. V_{DS}

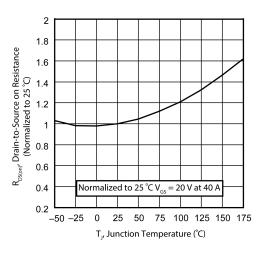


Figure 5 • RDS(on) vs. Junction Temperature

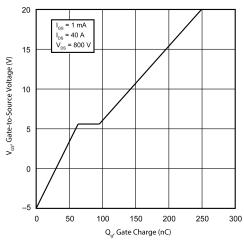


Figure 6 • Gate Charge Characteristics

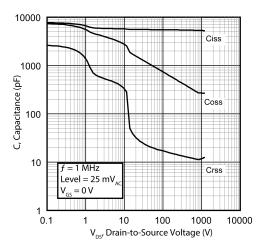


Figure 7 • Capacitance vs. Drain-to-Source Voltage

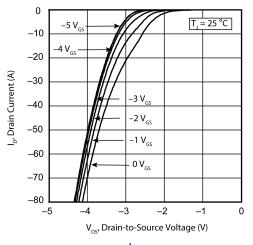


Figure 8 • I_D vs. V_{DS} 3rd Quadrant Conduction



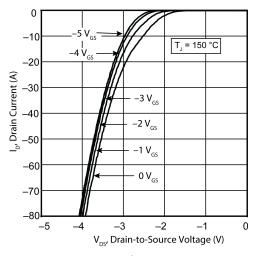


Figure 9 ● I_D vs. V_{DS} 3rd Quadrant Conduction

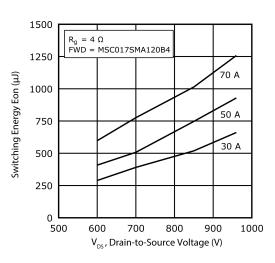


Figure 10 • Switching Energy Eon vs. V_{DS} & I_D

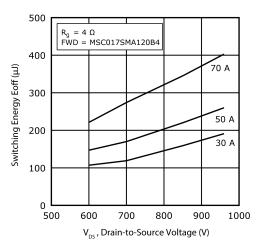


Figure 11 • Switching Energy Eoff vs. $V_{DS} \& I_{D}$

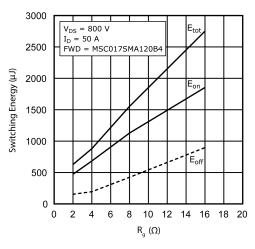


Figure 12 • Switching Energy vs. R_g

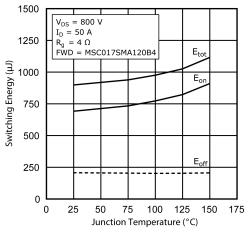


Figure 13 • Switching Energy vs. Temperature

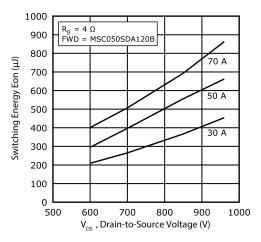


Figure 14 • Switching Energy Eon vs. V_{DS} & I_D



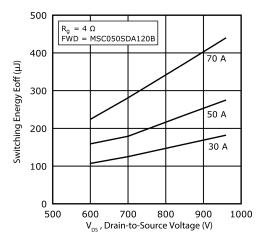


Figure 15 • Switching Energy Eoff vs. V_{DS} & I_D

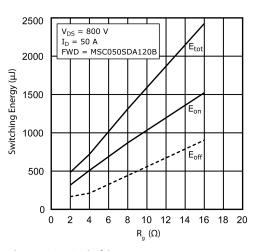


Figure 16 • Switching Energy vs. R_g

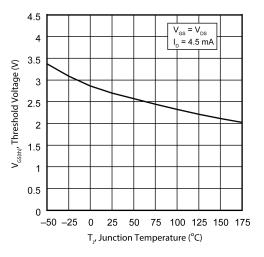


Figure 17 • Threshold Voltage vs. Junction Temp.

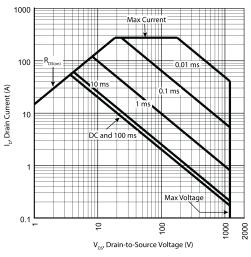


Figure 18 • Forward Safe Operating Area

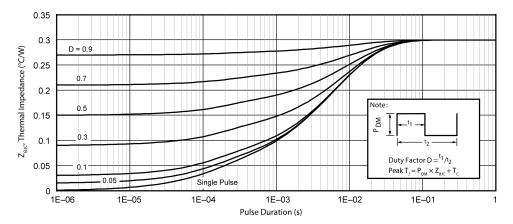


Figure 19 • Maximum Transient Thermal Impedance



Package Specification

This section shows the package specification of the MSC017SMA120B4 device.

Package Outline Drawing

The following figure illustrates the TO-247 4-lead package outline of the MSC017SMA120B4 device.

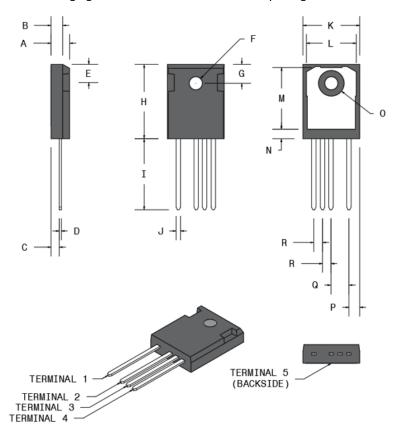


Figure 20 • Package Outline Drawing

The following table shows the TO-247 4-lead dimensions and should be used in conjunction with the package outline drawing.

Table 6 • TO-247-4L Dimensions

Symbol	Min (mm)	Max (mm)	Min (in.)	Max (in.)
А	4.90	5.17	0.193	0.204
В	1.85	2.11	0.073	0.083
С	2.25	2.51	0.089	0.099
D	0.55	0.68	0.022	0.027
Е	5.49	5.74	0.216	0.226



Symbol	Min (mm)	Max (mm)	Min (in.)	Max (in.)		
F	3.56	3.66	0.140	0.144		
G	6.15 BSC		0.242 BSC			
н	20.83	21.08	0.820	0.830		
I	19.81	20.32	0.780	0.800		
J	1.07	1.33	0.042	0.052		
К	15.77	16.03	0.621	0.631		
L	13.89	14.15	0.547	0.557		
М	16.25	16.85	0.640	0.663		
N	2.00	2.75	0.079	0.108		
0	7.10	7.50	0.280	0.295		
Р	2.87 BSC		0.113 BSC	GC .		
Q	5.08 BSC		0.200 BSC			
R	2.54 BSC		0.100 BSC			
Terminal 1	Drain					
Terminal 2	Source					
Terminal 3	Source sense					
Terminal 4	Gate					
Terminal 5	Drain					





Microsemi

2355 W. Chandler Blvd. Chandler, AZ 85224 USA

Within the USA: +1 (480) 792-7200 Fax: +1 (480) 792-7277

www.microsemi.com © 2020 Microsemi and its corporate affiliates. All rights reserved. Microsemi and the Microsemi logo are trademarks of Microsemi Corporation and its corporate affiliates. All other trademarks and service marks are the property of their respective owners.

Microsemi's product warranty is set forth in Microsemi's Sales Order Terms and Conditions. Information contained in this publication is provided for the sole purpose of designing with and using Microsemi products. Information regarding device applications and the like is provided only for your convenience and may be superseded by updates. Buyer shall not rely on any data and performance specifications or parameters provided by Microsemi. It is your responsibility to ensure that your application meets with your specifications. THIS INFORMATION IS PROVIDED "AS IS." MICROSEMI MAKES NO REPRESENTATIONS OR WARRANTIES OF ANY KIND WHETHER EXPRESS OR IMPLIED, WRITTEN OR ORAL, STATUTORY OR OTHERWISE, RELATED TO THE INFORMATION, INCLUDING BUT NOT LIMITED TO ITS CONDITION, QUALITY, PERFORMANCE, NON-INFRINGEMENT, MERCHANTABILITY OR FITNESS FOR A PARTICULAR PURPOSE. IN NO EVENT WILL MICROSEMI BE LIABLE FOR ANY INDIRECT, SPECIAL, PUNITIVE, INCIDENTAL OR CONSEQUENTIAL LOSS, DAMAGE, COST OR EXPENSE WHATSOEVER RELATED TO THIS INFORMATION OR ITS USE, HOWEVER CAUSED, EVEN IF MICROSEMI HAS BEEN ADVISED OF THE POSSIBILITY OR THE DAMAGES ARE FORESEEABLE. TO THE FULLEST EXTENT ALLOWED BY LAW, MICROSEMI'S TOTAL LIABILITY ON ALL CLAIMS IN RELATED TO THIS INFORMATION OR ITS USE WILL NOT EXCEED THE AMOUNT OF FEES, IF ANY, YOU PAID DIRECTLY TO MICROSEMI FOR THIS INFORMATION. Use of Microsemi devices in life support, mission-critical equipment or applications, and/or safety applications is entirely at the buyer's risk, and the buyer agrees to defend and indemnify Microsemi from any and all damages, claims, suits, or expenses resulting from such use. No licenses are conveyed, implicitly or otherwise, under any Microsemi intellectual property rights unless otherwise stated.

Microsemi Corporation, a subsidiary of Microchip Technology Inc. (Nasdaq: MCHP), and its corporate affiliates are leading providers of smart, connected and secure embedded control solutions. Their easy-to-use development tools and comprehensive product portfolio enable customers to create optimal designs which reduce risk while lowering total system cost and time to market. These solutions serve more than 120,000 customers across the industrial, automotive, consumer, aerospace and defense, communications and computing markets. Headquartered in Chandler, Arizona, the company offers outstanding technical support along with dependable delivery and quality. Learn more at www.microsemi.com.

050-7777 | November 2020 | Preliminary